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## **AEC-Q101 Qualified 650V Cascode GaN FET in TO-247 (source tab)**

#### **Description**

The TPH3205WSBQA 650V,  $49m\Omega$  gallium nitride (GaN) FET is a normally-off device. Transphorm GaN FETs offer better efficiency through lower gate charge, faster switching speeds, and smaller reverse recovery charge, delivering significant advantages over traditional silicon (Si) devices.

Transphorm is a leading-edge wide band gap supplier with world-class innovation and a portfolio of fully-qualified GaN transistors that enables increased performance and reduced overall system size and cost.

#### **Related Literature**

- ANOOO9: Recommended External Circuitry for GaN FETs
- ANOOO3: Printed Circuit Board Layout and Probing
- ANOO10: Paralleling GaN FETs

### **Ordering Information**

Part Number	Package	Package Configuration	
TPH3205WSBQA	3 Lead TO-247	Common Source	

#### **TPH3205WSBQA T0-247** (top view)



#### **Features**

- Easy to drive—compatible with standard gate drivers
- Low conduction and switching losses
- Low Qrr of 136nC-no free-wheeling diode required
- GSD pin layout improves high speed design
- JEDEC-qualified GaN technology
- · RoHS compliant and Halogen-free
- AEC-Q101 qualified

#### **Benefits**

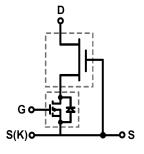
- · Increased efficiency through fast switching
- · Increased power density
- · Reduced system size and weight
- Enables more efficient topologies—easy to implement bridgeless totem-pole designs
- Lower BOM cost

#### **Applications**

- Automotive
- · Renewable energy
- Industrial
- Telecom and datacom
- Servo motors

Key Specifications			
V <sub>DS</sub> (V) min	650		
V <sub>TDS</sub> (V) max	800		
$R_{DS(on)}(m\Omega)$ max*	62		
Q <sub>rr</sub> (nC) typ	136		
Qg (nC) typ	28		

<sup>\*</sup> Dynamic RDS(on)



**Cascode Device Structure** 

### **Absolute Maximum Ratings** (T<sub>C</sub>=25 °C unless otherwise stated)

Symbol	Parameter	,	Limit Value	Unit
I <sub>D25°C</sub>	Continuous drain current @Tc=25	Continuous drain current @T <sub>C</sub> =25°C a		A
I <sub>D100°C</sub>	Continuous drain current @Tc=10	00°C a	22.3	A
I <sub>DM</sub>	Pulsed drain current (pulse width	: 10µs)	150	A
V <sub>DSS</sub>	Drain to source voltage	Drain to source voltage		V
V <sub>TDS</sub>	Transient drain to source voltage b		800	V
V <sub>GSS</sub>	Gate to source voltage		±18	V
P <sub>D25°C</sub>	Maximum power dissipation		125	W
T <sub>C</sub>	Operating temperature	Case	-55 to +150	°C
TJ	Operating temperature	Junction	-55 to +150	°C
Ts	Storage temperature		-55 to +150	°C
T <sub>CSOLD</sub>	Soldering peak temperature c		260	°C
-	Mounting Torque		60	N cm

### **Thermal Resistance**

Symbol	Parameter	Typical	Unit
R <sub>OJC</sub>	Junction-to-case	1	°C/W
R <sub>OJA</sub>	Junction-to-ambient	40	°C/W

#### Notes:

a. For high current operation, see application note AN0009
b. In off-state, spike duty cycle D<0.01, spike duration <1µs</li>

For 10 sec., 1.6mm from the case

### **Electrical Parameters** (T<sub>C</sub>=25 °C unless otherwise stated)

Symbol	Parameter	Min	Тур	Max	Unit	Test Conditions	
Forward	Device Characteristics		'				
V <sub>DSS-MAX</sub>	Maximum drain-source voltage	650	_	_	V	V <sub>GS</sub> =0V	
$V_{\text{GS(th)}}$	Gate threshold voltage <sup>d</sup>	1.6	2.1	2.6	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =0.7mA	
R <sub>DS(on)</sub>	Drain-source on-resistance (T <sub>J</sub> =25°C) <sup>a</sup>	_	49	62	0	V <sub>GS</sub> =8V, I <sub>D</sub> =22A, T <sub>J</sub> =25°C	
	Drain-source on-resistance (T <sub>J</sub> =150°C) <sup>a</sup>	_	105	_	mΩ	V <sub>GS</sub> =8V, I <sub>D</sub> =22A, T <sub>J</sub> =150°C	
I <sub>DSS</sub>	Drain-to-source leakage current (T <sub>J</sub> =25°C)	_	4	40	μΑ	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	
IDSS	Drain-to-source leakage current (T <sub>J</sub> =150°C)	_	50	_	μΛ	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V, T <sub>J</sub> =150°C	
1	Gate-to-source forward leakage current	_	_	100	nA	V <sub>GS</sub> =18V	
I <sub>GSS</sub>	Gate-to-source reverse leakage current	_	_	-100	IIA	V <sub>GS</sub> =-18V	
C <sub>ISS</sub>	Input capacitance	_	2200	_			
Coss	Output capacitance	_	135	_	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =400V, <i>f</i> =1MHz	
C <sub>RSS</sub>	Reverse transfer capacitance	_	23	_			
C <sub>O(er)</sub>	Output capacitance, energy related <sup>b</sup>	_	190	_	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V to 400V	
$C_{O(tr)}$	Output capacitance, time related °	_	300	_			
Qg	Total gate charge	_	28	42			
Qgs	Gate-source charge	_	10	_	nC	V <sub>DS</sub> =400V, V <sub>GS</sub> =0V to 8V, I <sub>D</sub> =22	
Q <sub>gd</sub>	Gate-drain charge	_	6	_			
t <sub>d(on)</sub>	Turn-on delay	_	36	_			
t <sub>r</sub>	Rise time	_	7.6	_		$V_{DS}$ =400V, $V_{GS}$ =0V to 8V, $I_{D}$ =22A, $R_{G}$ =4 $\Omega$ including driver output resistance (See Figure 13)	
T <sub>d(off)</sub>	Turn-off delay	_	40	_	ns		
t <sub>f</sub>	Fall time	_	8.6	_	•		
Reverse	Device Characteristics			ı	ı		
Is	Reverse current	_	_	22	А	V <sub>GS</sub> =0V, T <sub>C</sub> =100°C ≤50% Duty Cycle	
V <sub>SD</sub> Rev	Povorco voltago a	_	2.0	2.4	V	V <sub>GS</sub> =0V, I <sub>S</sub> =22A, T <sub>J</sub> =25°C	
	Reverse voltage a	_	1.5	1.7		V <sub>GS</sub> =0V, I <sub>S</sub> =11A, T <sub>J</sub> =25°C	
t <sub>rr</sub>	Reverse recovery time	_	40	_	ns	di/d+=10004/ T = 25 °C	
Qrr	Reverse recovery charge	_	136	_	nC		

#### Notes:

- Dynamic value
- b.
- Equivalent capacitance to give same stored energy from 0V to 400V
  Equivalent capacitance to give same charging time from 0V to 400V
  Recommended gate drive: Turn on +8V, turn off 0 or -5V. For half bridge, use isolated driver ICs with 5V UVLO.

### Typical Characteristics (25 °C unless otherwise stated)

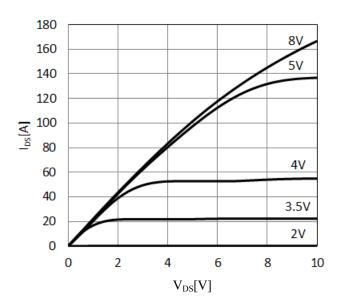


Figure 1. Typical Output Characteristics T<sub>J</sub>=25 °C

Parameter: V<sub>GS</sub>

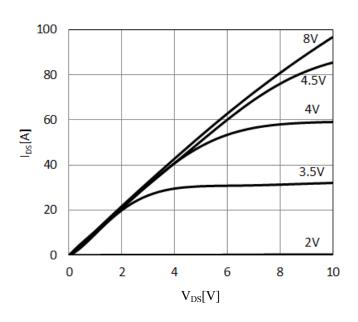


Figure 2. Typical Output Characteristics T<sub>J</sub>=150 °C
Parameter: V<sub>GS</sub>

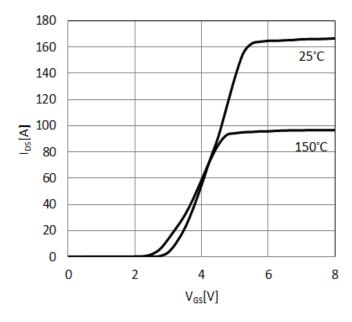


Figure 3. Typical Transfer Characteristics  $V_{DS}$ =10V, parameter:  $T_J$ 

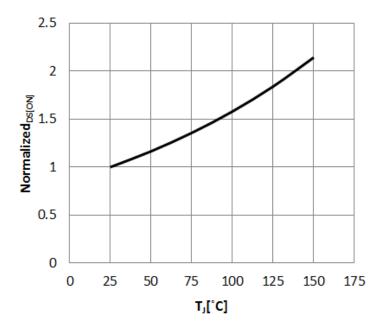
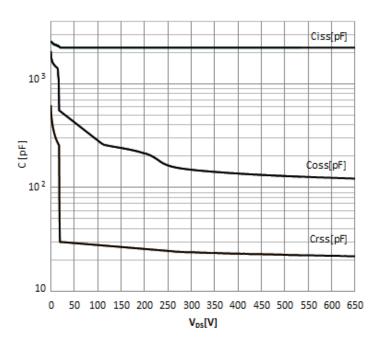


Figure 4. Normalized On-Resistance  $I_D=22A,\ V_{GS}=8V$ 

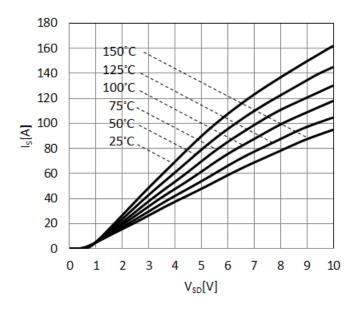
### Typical Characteristics (25 °C unless otherwise stated)



35 30 25 15 10 0 50 100 150 200 250 300 350 400 450 500 550 600 650 V<sub>DS</sub>[V]

Figure 5. Typical Capacitance  $V_{GS}$ =0V, f=1MHz

Figure 6. Typical Coss Stored Energy



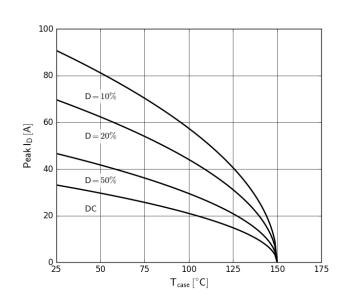


Figure 7. Forward Characteristics of Rev. Diode  $I_S=f(V_{SD})$ ; parameter:  $T_J$ ; pulse width = 20 $\mu$ s

Figure 8. Current Derating
Pulse width ≤ 10µs

### Typical Characteristics (25 °C unless otherwise stated)

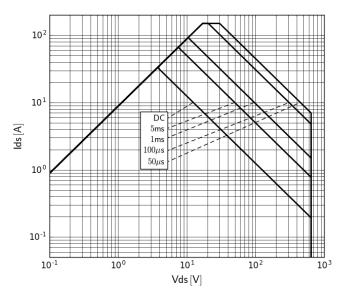


Figure 9. Safe Operating Area T<sub>C</sub>=25 °C (calculated based on thermal limit)

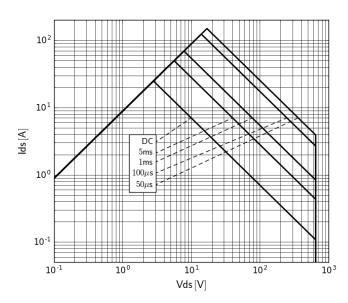


Figure 10. Safe Operating Area T<sub>C</sub>=80 °C (calculated based on thermal limit)

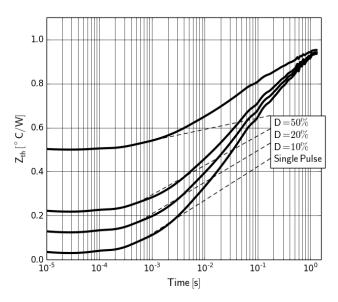


Figure 11. Transient Thermal Resistance

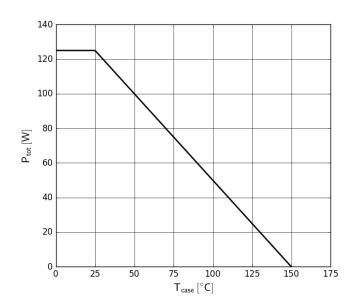


Figure 12. Power Dissipation

### **Test Circuits and Waveforms**

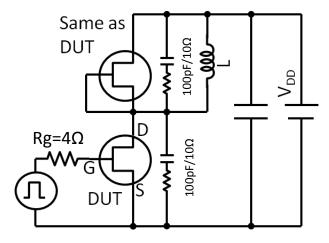


Figure 13. Switching Time Test Circuit
\*See app note AN0009 for methods to ensure clean switching

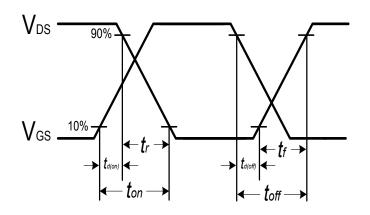


Figure 14. Switching Time Waveform

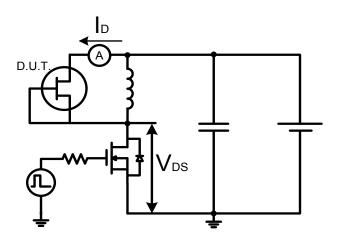


Figure 15. Test Circuit for Diode Characteristics

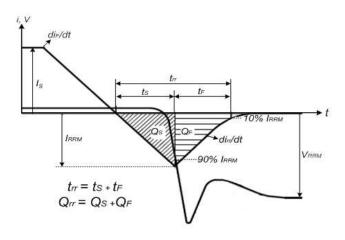


Figure 16. Diode Recovery Waveform

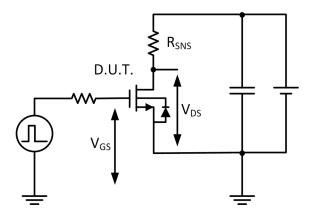


Figure 17. Test Circuit for Dynamic R<sub>DS(on)</sub>

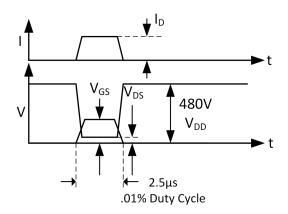
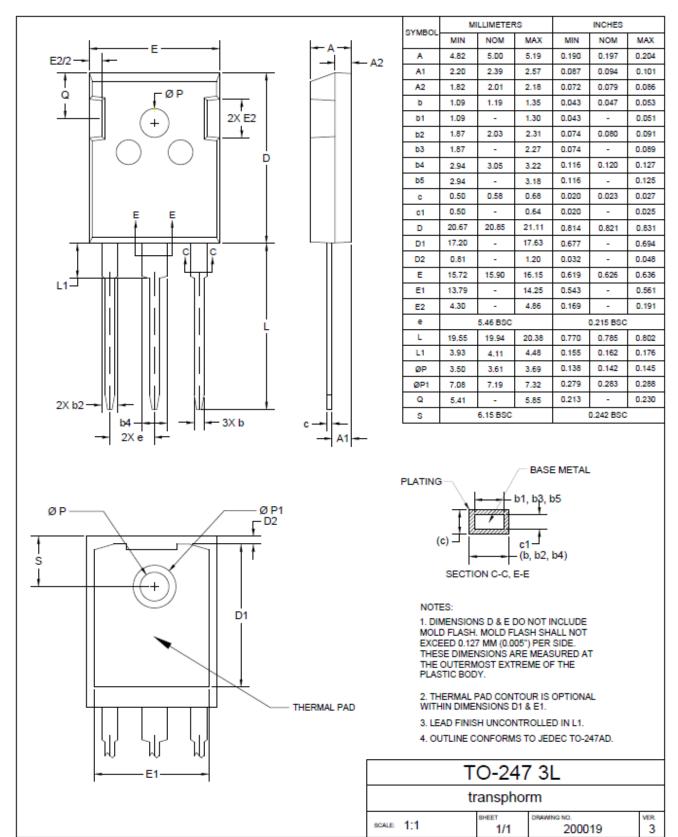


Figure 18. Dynamic R<sub>DS(on)</sub> Waveform

#### Mechanical

### 3 Lead TO-247 Package



### **Design Considerations**

The fast switching of GaN devices reduces current-voltage cross-over losses and enables high frequency operation while simultaneously achieving high efficiency. However, taking full advantage of the fast switching characteristics of GaN switches requires adherence to specific PCB layout guidelines and probing techniques.

Before evaluating Transphorm GaN devices, see application note <u>Printed Circuit Board Layout and Probing for GaN Power Switches</u>. The table below provides some practical rules that should be followed during the evaluation.

### **When Evaluating Transphorm GaN Devices:**

DO	DO NOT
Minimize circuit inductance by keeping traces short, both in the drive and power loop	Twist the pins of T0-220 or T0-247 to accommodate GDS board layout
Minimize lead length of TO-220 and TO-247 package when mounting to the PCB	Use long traces in drive circuit, long lead length of the devices
Use shortest sense loop for probing; attach the probe and its ground connection directly to the test points	Use differential mode probe or probe ground clip with long wire
See AN0003: Printed Circuit Board Layout and Probing	

#### **Application Notes**

- ANOOO2: Characteristics of Transphorm GaN Power Switches
- ANOOO3: Printed Circuit Board Layout and Probing
- ANOOO4: Designing Hard-switched Bridges with GaN
- ANOOO8: Drain Voltage and Avalanche Ratings for GaN FETs
- ANOOO9: Recommended External Circuitry for GaN FETs
- ANOO10: GaN FETs in Parallel Using Drain Ferrite Beads and RC Snubbers for High-power Applications

#### **Evaluation Boards**

- TDPS2800E2C1-KIT: 2.8kW totem-pole PFC evaluation platform
- TDPS3500E0E10-KIT: 3.5kW hard-switched half-bridge, buck, or boost evaluation platform

## **Revision History**

Version	Date	Change(s)	
0	3/1/2017	QA version denotes Q101 qualification	